Notice	of References	Cited
--------	---------------	-------

Application/Control No.	Applicant(s)/Pater	nt Under
10/749,682	Reexamination PHILLIPS ET AL.	
Examiner	Art Unit	
MARK FADOK	3625	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2004/0153424	08-2004	Lussow et al.	705/400
*	В	US-2004/0153370	08-2004	Yang, Ping	705/026
*	O	US-2003/0217017	11-2003	Willoughby et al.	705/404
*	D	US-2003/0033260	02-2003	Yashiro et al.	705/400
*	Е	US-2002/0152093	10-2002	Chalmers et al.	705/1
*	F	US-2002/0032613	03-2002	Buettgenbach et al.	705/26
*	G	US-2002/0013744	01-2002	Tsunenari et al.	705/28
*	Н	US-7,266,513	09-2007	Chalmers et al.	705/26
*	_	US-7,076,449	07-2006	Tsunenari et al.	705/26
	J	US-			
	К	US-			
	L	US-			
	м	US-			

FOREIGN PATENT DOCUMENTS

FOREIGN PATENT DOCUMENTS						
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	s					
	Т					

NON DATENT DOCUMENTS

*	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	U				
	v				
	w				
	x				

"A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.